

MI8402-VB Datasheet

N-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^a	Q _g (TYP.)			
20	0.0055 at V _{GS} = 4.5V	58	9.4 nC			
	0.0057 at V _{GS} = 2.5 V	45	9.4 110			

FEATURES

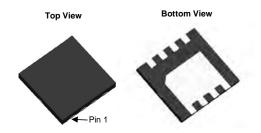
- Trench power MOSFET
- 100 % R_g and UIS tested

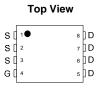
RoHS COMPLIANT HALOGEN FREE

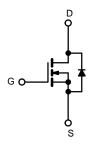
APPLICATIONS

- High power density DC/DC
- Synchronous rectification
- Embedded DC/DC









N-Channel MOSFET

PARAMETER	SYMBOL	LIMIT	UNIT	
Drain-Source Voltage	V _{DS}	20	v	
Gate-Source Voltage	V _{GS}	+12		
	T _C = 25 °C		58	
Continuous Drain Current /T 150 °C)	T _C = 70 °C	46	46	
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	19.8 ^{b, c}	
	T _A = 70 °C		15.8 ^{b, c}	
Pulsed Drain Current (t = 300 μs)	I _{DM}	150	Α	
Continuous Source-Drain Diode Current	T _C = 25 °C		14.1	
Continuous Source-Drain Diode Current	T _A = 25 °C	l _S	3.2 b, c	
Single Pulse Avalanche Current	l 0.1 mll	I _{AS}	15	
Single Pulse Avalanche Energy	L = 0.1 mH		11.25	mJ
	T _C = 25 °C		31.2	
Mayimum Bayyar Dissination	T _C = 70 °C		20	w
Maximum Power Dissipation	T _A = 25 °C	P _D	3.6 ^{b, c}	vv
	T _A = 70 °C		2.3 b, c	
Operating Junction and Storage Temperature R	T _J , T _{stg}	-55 to 150	**	
Soldering Recommendations (Peak Temperatur		260	°C	

THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYPICAL	MAXIMUM	UNIT		
Maximum Junction-to-Ambient b, f	t ≤ 10 s	R_{thJA}	24	34	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R_{thJC}	3	4		

Notes

- a. Based on $T_C = 25$ °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. The DFN3X3 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: Manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 70 °C/W.



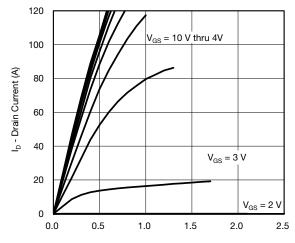
SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static	•			I.	I.		
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	20	-	-	١,,	
Drain-Source Breakdown Voltage (transient) c	V _{DSt}	$V_{GS} = 0 \text{ V}, I_{D(aval)} = 15 \text{ A}, t_{transient} = 50 \text{ ns}$	26	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	- I _D = 250 μA		20	-	mV/°	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			-4.6	-	С	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	0.5	-	1.5	V	
Gate-Source Leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = 12V	-	-	± 100	nA	
Zone Cote Veltage Drain Comment		V _{DS} = 20 V, V _{GS} = 0 V	-	-	1		
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 20 V, V _{GS} = 0 V, T _J = 55 °C	-	-	10	μA	
On-State Drain Current ^a	I _{D(on)}	V _{DS} ≥ 5 V, V _{GS} = 10 V	30	-	-	Α	
Drain Course On State Besistance 3	Б	$V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$	-	0.0055	-	Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 2.5 V, I _D = 8 A	-	0.0057	-		
Forward Transconductance a	9fs	V _{DS} = 10 V, I _D = 10 A	-	65	-	S	
Dynamic ^b							
Input Capacitance	C _{iss}			1450	-		
Output Capacitance	Coss	\ 15\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	-	445	-		
Reverse Transfer Capacitance	C _{rss}	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz		38	-	pF -	
C _{rss} /C _{iss} Ratio				0.026	0.052		
Table 1 Oaks Observe	Qg	V _{DS} = 15 V, V _{GS} = 10 V, I _D = 10 A	-	19.4	29		
Total Gate Charge			=	9.4	14		
Gate-Source Charge	Q _{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$		4	-	nC	
Gate-Drain Charge	Q_{gd}		=	1.8	-		
Output Charge	Q _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}$	=.	12.5	-		
Gate Resistance	R_g	f = 1 MHz	0.4	1.65	3.3	Ω	
Turn-On Delay Time	t _{d(on)}		=	9	18		
Rise Time	t _r	$V_{DD} = 15 \text{ V}, R_{L} = 1.5 \Omega$		8	16	1]	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	=.	18	36	1	
Fall Time	t _f		-	8	16		
Turn-On Delay Time	t _{d(on)}		-	15	30	ns	
Rise Time	t _r	$V_{DD} = 15 \text{ V}, R_{L} = 1.5 \Omega$	-	12	24	1	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		18	36		
Fall Time	t _f			9	18		
Drain-Source Body Diode Characteristics							
Continuous Source-Drain Diode Current	Is	T _C = 25 °C	-	-	14.1	۸	
Pulse Diode Forward Current ^a	I _{SM}		-	-	80	A	
Body Diode Voltage	V_{SD}	I _S = 3 A	=.	0.76	1.1	V	
Body Diode Reverse Recovery Time	t _{rr}		-	24	48	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 10 A, dl/dt = 100 A/μs,	-	14	28	nC	
Reverse Recovery Fall Time	t _a	T _J = 25 °C	-	12	-		
Reverse Recovery Rise Time	t _b	†		12	-	ns	

Notes

- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.
- c. $T_{CASE} = 25$ °C. Expected voltage stress during 100 % UIS test. Production datalog is not available.

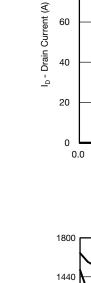
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.





 ${\rm V}_{\rm DS}$ - Drain-to-Source Voltage (V)

Output Characteristics



80

60

T_C = 25 °C

= 125 °C

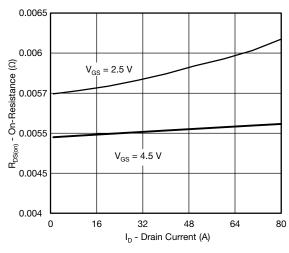
1.0

2.0 3.0 4.0 5.0 V_{GS} - Gate-to-Source Voltage (V)

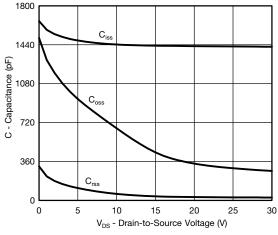
T_C = - 55 °C

6.0

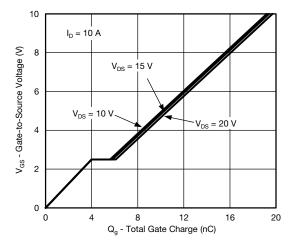




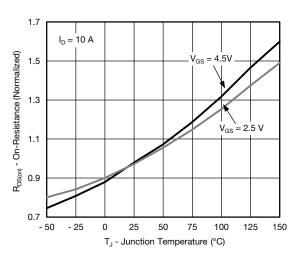
On-Resistance vs. Drain Current



Capacitance

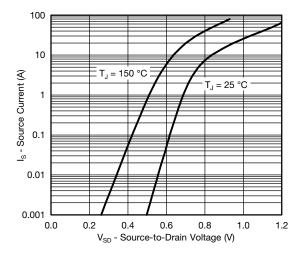


Gate Charge

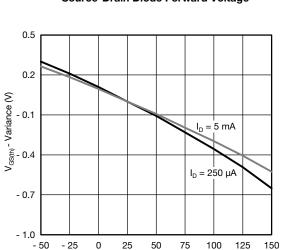


On-Resistance vs. Junction Temperature



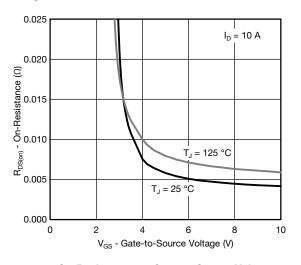


Source-Drain Diode Forward Voltage

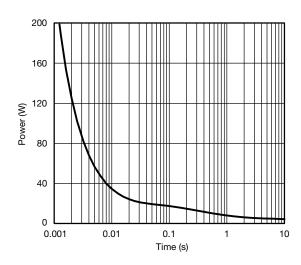


Threshold Voltage

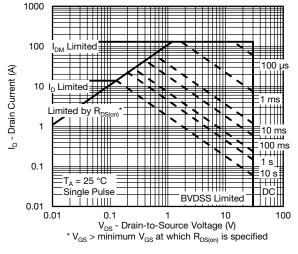
T_J - Temperature (°C)



On-Resistance vs. Gate-to-Source Voltage

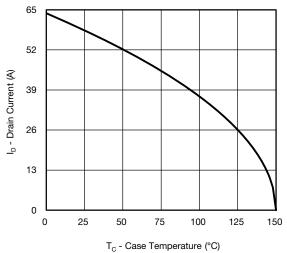


Single Pulse Power, Junction-to-Ambient

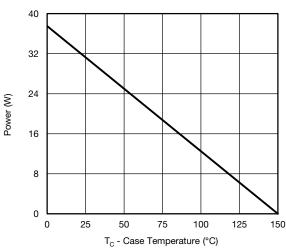


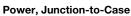
Safe Operating Area

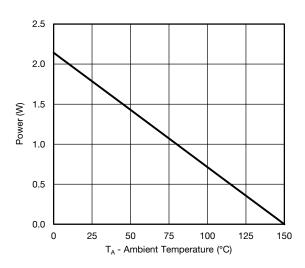




Current Derating*



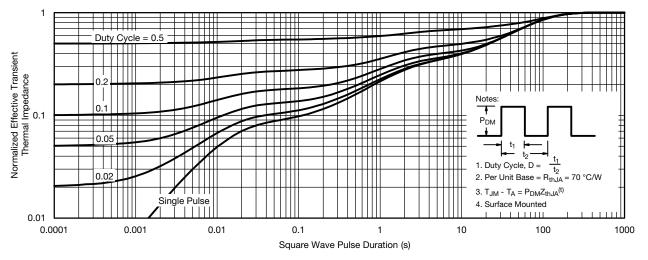




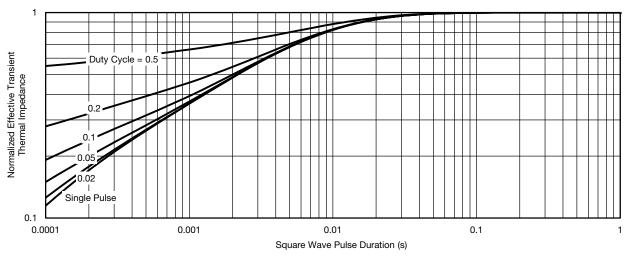
Power, Junction-to-Ambient

 $^{^{\}star}$ The power dissipation P_D is based on T_{J (max.)} = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



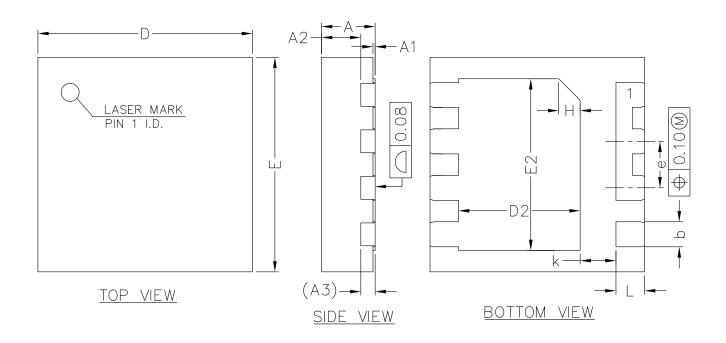


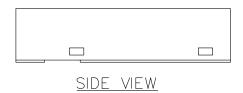
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case







COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	NOM	MAX		
Α	0.70	0.75	0.80		
A1	0.00	0.02	0.05		
A2	0.50	0.55	0.60		
А3	0.20REF				
b	0.30	0.35	0.40		
D	2.90	3.00	3.10		
Ε	2.90	3.00	3.10		
D2	1.60	1.70	1.80		
E2	2.30	2.40	2.50		
е	0.55	0.65	0.75		
K	0.40	0.50	0.60		
L	0.35	0.40	0.45		

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